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**PRODUCT RELIABILITY REPORT
FOR**

DS1682, Rev A5

Dallas Semiconductor

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Prepared by:

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Conclusion:

The following qualification successfully meets the quality and reliability standards required of all Dallas Semiconductor products:

DS1682, Rev A5

In addition, Dallas Semiconductor's continuous reliability monitor program ensures that all outgoing product will continue to meet Maxim's quality and reliability standards. The current status of the reliability monitor program can be viewed at <http://www.maxim-ic.com/TechSupport/dsreliability.html>.

Device Description:

A description of this device can be found in the product data sheet. You can find the product data sheet at http://dbserv.maxim-ic.com/l_datasheet3.cfm.

Reliability Derating:

The Arrhenius model will be used to determine the acceleration factor for failure mechanisms that are temperature accelerated.

$$AfT = \exp((Ea/k) * (1/Tu - 1/Ts)) = tu/ts$$

AfT = Acceleration factor due to Temperature
tu = Time at use temperature (e.g. 55°C)
ts = Time at stress temperature (e.g. 125°C)
k = Boltzmann's Constant (8.617 x 10⁻⁵ eV/°K)
Tu = Temperature at Use (°K)
Ts = Temperature at Stress (°K)
Ea = Activation Energy (e.g. 0.7 ev)

The activation energy of the failure mechanism is derived from either internal studies or industry accepted standards, or activation energy of 0.7ev will be used whenever actual failure mechanisms or their activation energies are unknown. All deratings will be done from the stress ambient temperature to the use ambient temperature.

An exponential model will be used to determine the acceleration factor for failure mechanisms, which are voltage accelerated.

$$AfV = \exp(B * (Vs - Vu))$$

AfV = Acceleration factor due to Voltage
Vs = Stress Voltage (e.g. 7.0 volts)
Vu = Maximum Operating Voltage (e.g. 5.5 volts)
B = Constant related to failure mechanism type (e.g. 1.0, 2.4, 2.7, etc.)

The Constant, B, related to the failure mechanism is derived from either internal studies or industry accepted standards, or a B of 1.0 will be used whenever actual failure mechanisms or their B are unknown. All deratings will be done from the stress voltage to the maximum operating voltage. Failure rate data from the operating life test is reported using a Chi-Squared statistical model at the 60% or 90% confidence level (Cf).

The failure rate, Fr, is related to the acceleration during life test by:

$$Fr = X / (ts * AfV * AfT * N * 2)$$

X = Chi-Sq statistical upper limit
N = Life test sample size

Failure Rates are reported in FITs (Failures in Time) or MTTF (Mean Time To Failure). The FIT rate is related to MTTF by:

$$MTTF = 1/Fr$$

NOTE: MTTF is frequently used interchangeably with MTBF.

The calculated failure rate for this device/process is:

FAILURE RATE:	MTTF (YRS):	376868	FITS:	0.3
	DEVICE HOURS:	3207284	FAILS:	0

Only data from Operating Life or similar stresses are used for this calculation.

The parameters used to calculate this failure rate are as follows:

Cf: 60% **Ea: 0.7** **B: 0** **Tu: 25 °C** **Vu: 5.5 Volts**

The reliability data follows. At the start of this data is the device information. The next section is the detailed reliability data for each stress. The reliability data section includes the latest data available and may contain some generic data. "*" after DATE CODE denotes specific product data and SEQ No. to identify specific line items in the report for comments when required.

Device Information:

Process: E6W-2P2M,HPVt,E2,EPROGVt,TCZ ALOCOS:GOI 5" Reticles
 Passivation: Passivation w/Nov TEOS Oxide-Nitride
 Die Size: 83 x 94
 Number of Transistors: 24000
 Interconnect: Aluminum / 0.5% Copper
 Gate Oxide Thickness: 150 Å

ELECTRICAL CHARACTERIZATION

DESCRIPTION	DATE CODE/SEQ	CONDITION	READPOINT	QTY	FAILS	FA#
ESD SENSITIVITY	0714 * 1	EOS/ESD S5.1 HBM 500 VOLTS	1 PUL'S	3	0	
ESD SENSITIVITY	0714 * 2	EOS/ESD S5.1 HBM 1000 VOLTS	1 PUL'S	3	0	
ESD SENSITIVITY	0714 * 3	EOS/ESD S5.1 HBM 2000 VOLTS	1 PUL'S	3	0	
ESD SENSITIVITY	0714 * 4	EOS/ESD S5.1 HBM 4000 VOLTS	1 PUL'S	3	0	
ESD SENSITIVITY	0714 * 5	EOS/ESD S5.1 HBM 8000 VOLTS	1 PUL'S	3	3	No FA
LATCH-UP	0714 * 6	JESD78, I-TEST 125C		6	0	
LATCH-UP	0714 * 7	JESD78, V-SUPPLY TEST 125C		6	0	
Total:					3	

OPERATING LIFE

DESCRIPTION	DATE CODE/SEQ	CONDITION	READPOINT	QTY	FAILS	FA#
HIGH TEMP OP LIFE	0335	125C, 5.5 VOLTS	1000 HRS	77	0	
HIGH TEMP OP LIFE	0345	125C, 5.25 VOLTS	1000 HRS	77	0	
		125C, 5.25 VOLTS	1000 HRS	77	0	
HIGH TEMP OP LIFE	0405	125C, 5.5 VOLTS	1000 HRS	45	0	
HIGH TEMP REVERSE BIAS	0416	125C, 5.5 VOLTS	1000 HRS	48	0	

HIGH TEMP OP LIFE	0416	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP REVERSE BIAS	0417	125C, 5.5 VOLTS	1000 HRS	48	0
HIGH TEMP REVERSE BIAS	0417	125C, 5.5 VOLTS	1000 HRS	48	0
HIGH TEMP OP LIFE	0417	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0418	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0418	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0424	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0425	125C, 5.5 VOLTS	1000 HRS	45	0
HIGH TEMP OP LIFE	0425	125C, 3.6V (PSA) & -4.0V (PSB)	1000 HRS	45	0
HIGH TEMP OP LIFE	0426	125C, 5.5 VOLTS	1000 HRS	45	0
HIGH TEMP OP LIFE	0427	125C, 5.5 VOLTS	1000 HRS	45	0
HIGH TEMP OP LIFE	0440	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0442	125C, 5.5 VOLTS	1000 HRS	62	0
HIGH TEMP OP LIFE	0442	125C, 5.5 VOLTS	1000 HRS	62	0
HIGH TEMP OP LIFE	0442	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP REVERSE BIAS	0443	125C, 5.25 VOLTS	1000 HRS	48	0
		125C, 5.25 VOLTS	1000 HRS	48	0
HIGH TEMP OP LIFE	0443	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0447	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP REVERSE BIAS	0447	125C, 5.5 VOLTS	1000 HRS	45	0
HIGH TEMP OP LIFE	0450	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH VOLTAGE LIFE	0452	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP REVERSE BIAS	0504	125C, 5.5 VOLTS	1000 HRS	45	0
HIGH TEMP REVERSE BIAS	0504	125C, 5.5 VOLTS	1000 HRS	45	0
HIGH TEMP OP LIFE	0507	125C, 5.5 V (PSA) & 17.0 V (PSB)	1000 HRS	45	0
HIGH TEMP REVERSE BIAS	0513	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0523	125C, 5.5 VOLTS	1000 HRS	45	0
HIGH TEMP OP LIFE	0524	125C, 5.5 VOLTS	1000 HRS	80	0
HIGH TEMP REVERSE BIAS	0525	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP REVERSE BIAS	0526	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0535	125C, 3.6 VOLTS	408 HRS	45	0

HIGH TEMP OP LIFE	0539	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0548	125C, 5.5V (PSA) & 3.6V (PSB)	1000 HRS	77	0
HIGH TEMP OP LIFE	0549	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0552	125C, 5.5 V (PSA) & 5.5 V (PSD)	1000 HRS	77	0
HIGH TEMP REVERSE BIAS	0611	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0612	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0623	125C, 5.5V (PSA), -7.0V (PSC) & +7.0V (PSD)	1000 HRS	77	0
HIGH TEMP OP LIFE	0626	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0626	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0635	125C, 5.25 VOLTS	1000 HRS	77	0
		125C, 5.25 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0635	125C, 5.5 VOLTS	500 HRS	77	0
HIGH TEMP OP LIFE	0645	125C, 5.5 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0712	125C, 5.5 VOLTS	192 HRS	45	0
HIGH TEMP OP LIFE	0714	* 1 125C, 5.5 VOLTS	192 HRS	77	0
Total:				0	0

W/E ENDURANCE AND DATA RET'N

DESCRIPTION	DATE CODE/SEQ	CONDITION	READPOINT	QTY	FAILS	FA#
WRITE CYCLE STRESS (KCYS)	0335	85 C, 5.5 VOLTS	25 KCYS	77	0	
STORAGE LIFE		150C	1000 HRS	76	0	
WRITE CYCLE STRESS (KCYS)	0401	25 C, 5.0 VOLTS	50 KCYS	76	0	
		25 C, 5.0 VOLTS	50 KCYS	76	0	
STORAGE LIFE		250C	4 HRS	76	0	
		250C	4 HRS	76	0	
WRITE CYCLE STRESS (KCYS)	0416	70 C, 5.5 VOLTS	30 KCYS	77	0	
STORAGE LIFE		150C	1000 HRS	77	0	
WRITE CYCLE STRESS (KCYS)	0418	55 C, 5.5 VOLTS	30 KCYS	77	0	
STORAGE LIFE		150C	1000 HRS	77	0	
WRITE CYCLE STRESS (KCYS)	0418	70 C, 5.5 VOLTS	30 KCYS	77	0	
STORAGE LIFE		150C	1000 HRS	77	0	
WRITE CYCLE STRESS (KCYS)	0424	85 C, 5.5 VOLTS	30 KCYS	77	0	
STORAGE LIFE		150C	1000 HRS	77	0	
WRITE CYCLE STRESS (KCYS)	0440	70 C, 5.5 VOLTS	30 KCYS	77	0	
STORAGE LIFE		150C	1000 HRS	77	0	

STORAGE LIFE	0519	150C	96	HRS	110	0
WRITE CYCLE STRESS (KCYS)	0519	70 C, 5.5 VOLTS	30	KCYS	110	0
STORAGE LIFE		150C	96	HRS	110	0
WRITE CYCLE STRESS (KCYS)	0519	70 C, 5.5 VOLTS	30	KCYS	110	0
STORAGE LIFE		150C	96	HRS	110	0
WRITE CYCLE STRESS (KCYS)	0519	70 C, 5.5 VOLTS	30	KCYS	110	0
STORAGE LIFE		150C	96	HRS	110	0
WRITE CYCLE STRESS (KCYS)	0519	70 C, 5.5 VOLTS	30	KCYS	110	0
STORAGE LIFE		150C	96	HRS	109	0
WRITE CYCLE STRESS (KCYS)	0519	70 C, 5.5 VOLTS	30	KCYS	110	0
STORAGE LIFE		150C	96	HRS	109	0
WRITE CYCLE STRESS (KCYS)	0519	70 C, 5.5 VOLTS	30	KCYS	110	0
STORAGE LIFE		150C	96	HRS	110	0
WRITE CYCLE STRESS (KCYS)	0519	70 C, 5.5 VOLTS	30	KCYS	110	0
STORAGE LIFE		150C	96	HRS	110	0
WRITE CYCLE STRESS (KCYS)	0523	70 C, 5.5 VOLTS	30	KCYS	77	0
STORAGE LIFE		150C	1000	HRS	75	0
WRITE CYCLE STRESS (KCYS)	0532	70 C, 5.5 VOLTS	30	KCYS	110	0
STORAGE LIFE		150C	96	HRS	109	0
WRITE CYCLE STRESS (KCYS)	0532	70 C, 5.5 VOLTS	30	KCYS	110	0
STORAGE LIFE		150C	96	HRS	110	0
WRITE CYCLE STRESS (KCYS)	0532	70 C, 5.5 VOLTS	30	KCYS	110	0
STORAGE LIFE		150C	96	HRS	110	0
WRITE CYCLE STRESS (KCYS)	0532	70 C, 5.5 VOLTS	30	KCYS	110	0
STORAGE LIFE		150C	96	HRS	110	0
WRITE CYCLE STRESS (KCYS)	0535	70 C, 3.6 VOLTS	10	KCYS	77	0
STORAGE LIFE		150C	500	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0539	55 C, 5.5 VOLTS	30	KCYS	77	0
STORAGE LIFE		150C	500	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0548	70 C, 5.5V (PSA) & 3.6V (PSB)	50	KCYS	77	0
STORAGE LIFE		150C	1000	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0549	85 C, 5.5 VOLTS	30	KCYS	77	0
STORAGE LIFE		150C	1000	HRS	77	0

WRITE CYCLE STRESS (KCYS)	0552	70C, +5.5V (PSA), +5.5V (PSD)	30	KCYS	77	0
STORAGE LIFE		150C	1000	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0612	70 C, 5.5 VOLTS	30	KCYS	77	0
STORAGE LIFE		150C	1000	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0623	70C, 5.5V (PSA), -7.0V (PSC) & +7.0V (PSD)	30	KCYS	77	0
STORAGE LIFE		150C	1000	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0626	85 C, 5.5 VOLTS	30	KCYS	77	0
STORAGE LIFE		150C	1000	HRS	75	0
WRITE CYCLE STRESS (KCYS)	0635	25 C, 5.0 VOLTS	50	KCYS	77	0
		25 C, 5.0 VOLTS	50	KCYS	77	0
STORAGE LIFE		150C	1000	HRS	77	0
		150C	1000	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0635	85 C, 5.5 VOLTS	30	KCYS	77	0
STORAGE LIFE		150C	1000	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0635	25 C, 5.5 VOLTS	50	KCYS	77	0
STORAGE LIFE		150C	1000	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0709	25 C, 5.5 VOLTS	200	KCYS	77	0
STORAGE LIFE		150C	96	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0712	70 C, 5.5 VOLTS	30	KCYS	77	0
STORAGE LIFE		150C	96	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0714	* 2 85 C, 5.5 VOLTS	30	KCYS	77	0
STORAGE LIFE		* 2 150C	96	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0720	70 C, 5.5 VOLTS	30	KCYS	77	

Total: 0

FAILURE RATE: MTTF (YRS): 376868 FITS: 0.3

DEVICE HOURS: 3207284 FAILS: 0